Notice of References Cited

Application/Control No. 10/797,007	Reexaminati	Applicant(s)/Patent Under Reexamination PENG ET AL.		
Examiner	Art Unit			
Muitaba K. Chaudry	2133	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0103360 A1	05-2004	Mori et al.	714/768
*	В	US-5,003,539 A	03-1991	Takemoto et al.	714/785
*	С	US-5,903,532 A	05-1999	Ikeda, Kenichi	369/59.25
*	D	US-5,745,508 A	04-1998	Prohofsky, Thomas Roy	714/766
*	E	US-6,662,335 B1	12-2003	Huang, Wei-Hung	714/769
*	F	US-2003/0103480 A1	06-2003	You et al.	370/335
*	G	US-6,170,073 B1	01-2001	Jarvinen et al.	714/758
*	Н	US-4,216,540 A	08-1980	McSpadden, Jeff R.	714/774
*	ı	US-7,139,962 B2	11-2006	Lin et al.	714/758
*	J	US-2003/0161239 A1	08-2003	Yamawaki, Masashi	369/59.25
	K	US-			
	L	US-	With the same of t		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.